

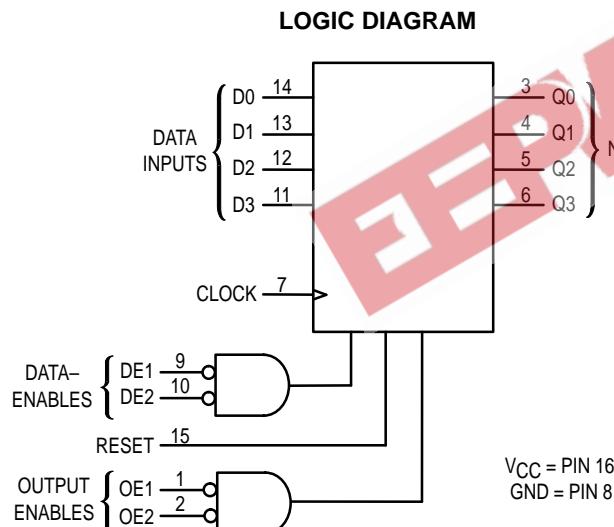
Quad 3-State D Flip-Flop with Common Clock and Reset

High-Performance Silicon-Gate CMOS

The MC74HC173A is identical in pinout to the LS173. The device inputs are compatible with standard CMOS outputs; with pullup resistors, they are compatible with LSTTL outputs.

Data, when enabled, are clocked into the four D flip-flops with the rising edge of the common Clock. When either or both of the Output Enable Controls is high, the outputs are in a high-impedance state. This feature allows the HC173A to be used in bus-oriented systems. The Reset feature is asynchronous and active high.

- Output Drive Capability: 15 LSTTL Loads
- Outputs Directly Interface to CMOS, NMOS, and TTL
- Operating Voltage Range: 2 to 6 V
- Low Input Current: 1 μ A
- High Noise Immunity Characteristic of CMOS Devices
- In Compliance with the Requirements Defined by JEDEC Standard No. 7A
- Chip Complexity 208 FETs or 52 Equivalent Gates



MC74HC173A



N SUFFIX
16-LEAD PLASTIC DIP PACKAGE
CASE 648-08



D SUFFIX
16-LEAD PLASTIC SOIC PACKAGE
CASE 751B-05

ORDERING INFORMATION

| | |
|-------------|---------|
| MC74HCXXXAN | Plastic |
| MC74HCXXXAD | SOIC |

PIN ASSIGNMENT

| | | | | |
|-------|---|---|----|-------|
| OE1 | 1 | ● | 16 | VCC |
| OE2 | 2 | | 15 | RESET |
| | 3 | | 14 | D0 |
| | 4 | | 13 | D1 |
| | 5 | | 12 | D2 |
| | 6 | | 11 | D3 |
| CLOCK | 7 | | 10 | DE2 |
| GND | 8 | | 9 | DE1 |

FUNCTION TABLE

| Inputs | | | | | Output | | |
|----------------|-----|-------|-------|--------------|--------|---|----------------|
| Output Enables | | Reset | Clock | Data Enables | | D | Q |
| OE1 | OE2 | | | DE1 | DE2 | | |
| L | L | H | X | X | X | X | L |
| L | L | L | L | X | X | X | No Change |
| L | L | L | H | X | X | X | No Change |
| L | L | L | / | H | X | X | No Change |
| L | L | L | / | X | H | X | No Change |
| L | L | L | / | L | L | L | L |
| L | L | L | / | L | L | H | H |
| L | L | L | ＼ | X | X | X | No Change |
| L | H | X | X | X | X | X | High Impedance |
| H | L | X | X | X | X | X | High Impedance |
| H | H | X | X | X | X | X | High Impedance |



MC74HC173A

MAXIMUM RATINGS*

| Symbol | Parameter | Value | Unit |
|-----------|--|-------------------------|------|
| V_{CC} | DC Supply Voltage (Referenced to GND) | – 0.5 to + 7.0 | V |
| V_{in} | DC Input Voltage (Referenced to GND) | – 0.5 to V_{CC} + 0.5 | V |
| V_{out} | DC Output Voltage (Referenced to GND) | – 0.5 to V_{CC} + 0.5 | V |
| I_{in} | DC Input Current, per Pin | ± 20 | mA |
| I_{out} | DC Output Current, per Pin | ± 35 | mA |
| I_{CC} | DC Supply Current, V_{CC} and GND Pins | ± 75 | mA |
| P_D | Power Dissipation in Still Air Plastic DIP† SOIC Package† | 750 500 | mW |
| T_{stg} | Storage Temperature | – 65 to + 150 | °C |
| T_L | Lead Temperature, 1 mm from Case for 10 Seconds (Plastic DIP or SOIC Package) | 260 | °C |

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation, V_{in} and V_{out} should be constrained to the range $GND \leq (V_{in} \text{ or } V_{out}) \leq V_{CC}$. Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or V_{CC}). Unused outputs must be left open.

* Maximum Ratings are those values beyond which damage to the device may occur.

Functional operation should be restricted to the Recommended Operating Conditions.

†Derating — Plastic DIP: – 10 mW/°C from 65° to 125°C

SOIC Package: – 7 mW/°C from 65° to 125°C

For high frequency or heavy load considerations, see Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | Min | Max | Unit | |
|-------------------|--|--|-------------|--------------------|----|
| V_{CC} | DC Supply Voltage (Referenced to GND) | 2.0 | 6.0 | V | |
| V_{in}, V_{out} | DC Input Voltage, Output Voltage (Referenced to GND) | 0 | V_{CC} | V | |
| T_A | Operating Temperature, All Package Types | – 55 | + 125 | °C | |
| t_r, t_f | Input Rise and Fall Time (Figure 1) | $V_{CC} = 2.0 \text{ V}$ $V_{CC} = 4.5 \text{ V}$ $V_{CC} = 6.0 \text{ V}$ | 0 0 0 | 1000 500 400 | ns |

DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)

| Symbol | Parameter | Test Conditions | V_{CC} V | Guaranteed Limit | | | Unit |
|----------|-----------------------------------|---|--------------------------|---------------------------|---------------------------|---------------------------|------|
| | | | | – 55 to 25°C | ≤ 85°C | ≤ 125°C | |
| V_{IH} | Minimum High-Level Input Voltage | $V_{out} = 0.1 \text{ V}$ or $V_{CC} - 0.1 \text{ V}$ $ I_{out} \leq 20 \mu\text{A}$ | 2.0 3.0 4.5 6.0 | 1.5 2.1 3.15 4.2 | 1.5 2.1 3.15 4.2 | 1.5 2.1 3.15 4.2 | V |
| V_{IL} | Maximum Low-Level Input Voltage | $V_{out} = 0.1 \text{ V}$ or $V_{CC} - 0.1 \text{ V}$ $ I_{out} \leq 20 \mu\text{A}$ | 2.0 3.0 4.5 6.0 | 0.5 0.9 1.35 1.8 | 0.5 0.9 1.35 1.8 | 0.5 0.9 1.35 1.8 | V |
| V_{OH} | Minimum High-Level Output Voltage | $V_{in} = V_{IH}$ or V_{IL} $ I_{out} \leq 20 \mu\text{A}$ | 2.0 4.5 6.0 | 1.9 4.4 5.9 | 1.9 4.4 5.9 | 1.9 4.4 5.9 | V |
| | | $V_{in} = V_{IH}$ or V_{IL} $ I_{out} \leq 3.6 \text{ mA}$ $ I_{out} \leq 6.0 \text{ mA}$ $ I_{out} \leq 7.8 \text{ mA}$ | 3.0 4.5 6.0 | 2.48 3.98 5.48 | 2.34 3.84 5.34 | 2.20 3.70 5.20 | |
| V_{OL} | Maximum Low-Level Output Voltage | $V_{in} = V_{IH}$ or V_{IL} $ I_{out} \leq 20 \mu\text{A}$ | 2.0 4.5 6.0 | 0.1 0.1 0.1 | 0.1 0.1 0.1 | 0.1 0.1 0.1 | V |
| | | $V_{in} = V_{IH}$ or V_{IL} $ I_{out} \leq 3.6 \text{ mA}$ $ I_{out} \leq 6.0 \text{ mA}$ $ I_{out} \leq 7.8 \text{ mA}$ | 3.0 4.5 6.0 | 0.26 0.26 0.26 | 0.33 0.33 0.33 | 0.40 0.40 0.40 | |

DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)

| Symbol | Parameter | Test Conditions | V _{CC} V | Guaranteed Limit | | | Unit |
|-----------------|--|---|----------------------|------------------|--------|---------|------|
| | | | | -55 to 25°C | ≤ 85°C | ≤ 125°C | |
| I _{in} | Maximum Input Leakage Current | V _{in} = V _{CC} or GND | 6.0 | ± 0.1 | ± 1.0 | ± 1.0 | µA |
| I _{OZ} | Maximum Three-State Leakage Current | Output in High-Impedance State V _{in} = V _{IL} or V _{IH} V _{out} = V _{CC} or GND | 6.0 | ± 0.5 | ± 5.0 | ± 10 | µA |
| I _{CC} | Maximum Quiescent Supply Current (per Package) | V _{in} = V _{CC} or GND I _{out} = 0 µA | 6.0 | 4 | 40 | 160 | µA |

NOTE: Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

AC ELECTRICAL CHARACTERISTICS (C_L = 50 pF, Input t_r = t_f = 6 ns)

| Symbol | Parameter | V _{CC} V | Guaranteed Limit | | | Unit |
|--|--|--------------------------|------------------------|------------------------|------------------------|------|
| | | | -55 to 25°C | ≤ 85°C | ≤ 125°C | |
| f _{max} | Maximum Clock Frequency (50% Duty Cycle) (Figures 1 and 5) | 2.0 3.0 4.5 6.0 | 6.0 10 30 35 | 4.8 8.0 24 28 | 4.0 6.0 20 24 | MHz |
| t _{PLH} , t _{PHL} | Maximum Propagation Delay, Clock to Q (Figures 1 and 5) | 2.0 3.0 4.5 6.0 | 175 150 35 30 | 220 175 44 37 | 265 220 53 45 | ns |
| t _{PHL} | Maximum Propagation Delay, Reset to Q (Figures 2 and 5) | 2.0 3.0 4.5 6.0 | 150 125 30 26 | 190 150 38 33 | 225 175 45 38 | ns |
| t _{PLZ} , t _{PHZ} | Maximum Propagation Delay, Output Enable to Q (Figures 3 and 6) | 2.0 3.0 4.5 6.0 | 150 125 30 26 | 190 150 38 33 | 225 175 45 38 | ns |
| t _{PZL} , t _{PZH} | Maximum Propagation Delay, Output Enable to Q (Figures 3 and 6) | 2.0 3.0 4.5 6.0 | 150 125 30 26 | 190 150 38 33 | 225 175 45 38 | ns |
| t _{TLH} , t _{THL} | Maximum Output Transition Time, Any Output (Figures 1 and 5) | 2.0 3.0 4.5 6.0 | 60 22 12 10 | 75 28 15 13 | 90 34 18 15 | ns |
| C _{in} | Maximum Input Capacitance | — | 10 | 10 | 10 | pF |
| C _{out} | Maximum Three-State Output Capacitance (Output in High-Impedance State) | — | 15 | 15 | 15 | pF |

NOTES:

- For propagation delays with loads other than 50 pF, see Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).
- Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

| C _{PD} | Power Dissipation Capacitance (Per Flip-Flop)* | Typical @ 25°C, V _{CC} = 5.0 V | | pF |
|-----------------|--|---|----|----|
| | | 35 | 35 | |

* Used to determine the no-load dynamic power consumption: P_D = C_{PD} V_{CC}²f + I_{CC} V_{CC}. For load considerations, see Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

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TIMING REQUIREMENTS (Input $t_r = t_f = 6$ ns)

| Symbol | Parameter | V_{CC} V | Guaranteed Limit | | | Unit |
|------------|--|--------------------------|---------------------------|---------------------------|---------------------------|------|
| | | | -55 to 25°C | ≤ 85°C | ≤ 125°C | |
| t_{su} | Minimum Setup Time, Input D or DE to Clock (Figure 4) | 2.0 3.0 4.5 6.0 | 100 75 20 17 | 125 100 25 21 | 150 125 30 26 | ns |
| t_h | Minimum Hold Time, Clock to Input D or DE (Figure 4) | 2.0 3.0 4.5 6.0 | 3 3 3 3 | 3 3 3 3 | 3 3 3 3 | ns |
| t_{rec} | Minimum Recovery Time, Reset Inactive to Clock (Figure 2) | 2.0 3.0 4.5 6.0 | 90 70 18 15 | 115 95 23 20 | 135 115 27 23 | ns |
| t_w | Minimum Pulse Width, Clock (Figure 1) | 2.0 3.0 4.5 6.0 | 80 65 16 14 | 100 90 20 17 | 120 110 24 20 | ns |
| t_w | Minimum Pulse Width, Reset (Figure 2) | 2.0 3.0 4.5 6.0 | 80 65 16 14 | 100 90 20 17 | 120 110 24 20 | ns |
| t_r, t_f | Maximum Input Rise and Fall Times (Figure 1) | 2.0 3.0 4.5 6.0 | 1000 800 500 400 | 1000 800 500 400 | 1000 800 500 400 | ns |

NOTE: Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

PIN DESCRIPTIONS

INPUTS

D0, D1, D2, D3 (Pins 14, 13, 12, 11)

4-bit data inputs. Data on these pins, when enabled by the Data-Enable Controls, are entered into the flip-flops on the rising edge of the clock.

CLOCK (Pin 7)

Clock input.

OUTPUTS

Q0, Q1, Q2, Q3 (Pins 3, 4, 5, 6)

3-state register outputs. During normal operation of the device, the outputs of the D flip-flops appear at these pins. During 3-state operation, these outputs assume a high-impedance state.

CONTROL INPUT

Reset (Pin 15)

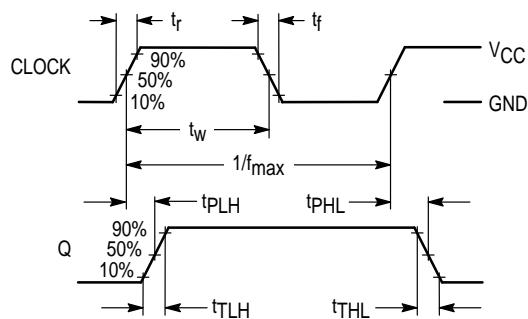
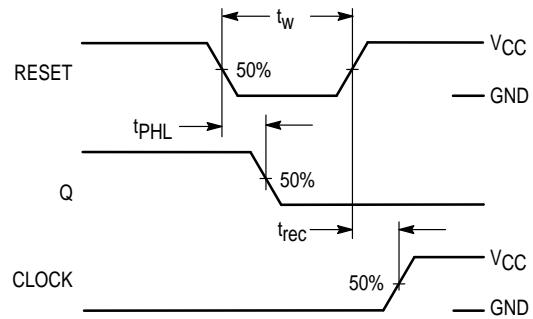
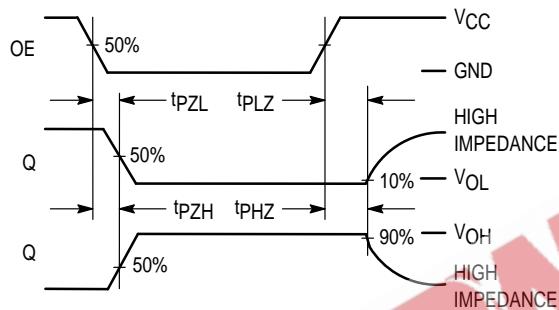
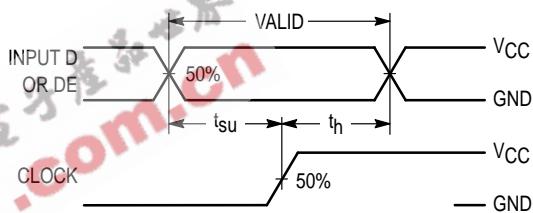
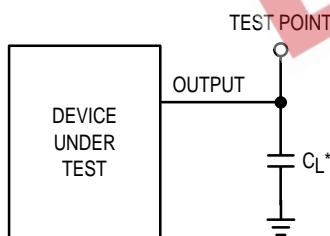
Asynchronous reset input. A high level on this pin resets all flip-flops and forces the Q outputs low, if they are not already in high-impedance state.

DE1, DE2 (Pins 9, 10)

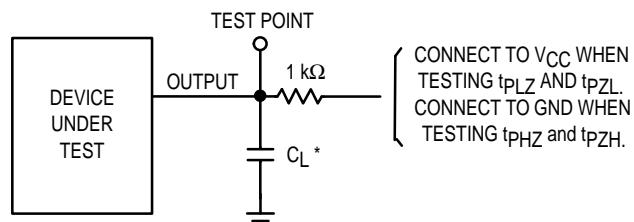
Active-low Data Enable Control inputs. When both Data Enable Controls are low, data at the D inputs are loaded into the flip-flops with the rising edge of the Clock input. When either or both of these controls are high, there is no change in the state of the flip-flops, regardless of any changes at the D or Clock inputs.

OE1, OE2 (Pins 1, 2)

Output Enable Control inputs. When either or both of the Output Enable Controls are high, the Q outputs of the device are in the high-impedance state. When both controls are low, the device outputs display the data in the flip-flops.

SWITCHING WAVEFORMS**Figure 1.****Figure 2.****Figure 3.****Figure 4.****TEST CIRCUITS**

* Includes all probe and jig capacitance

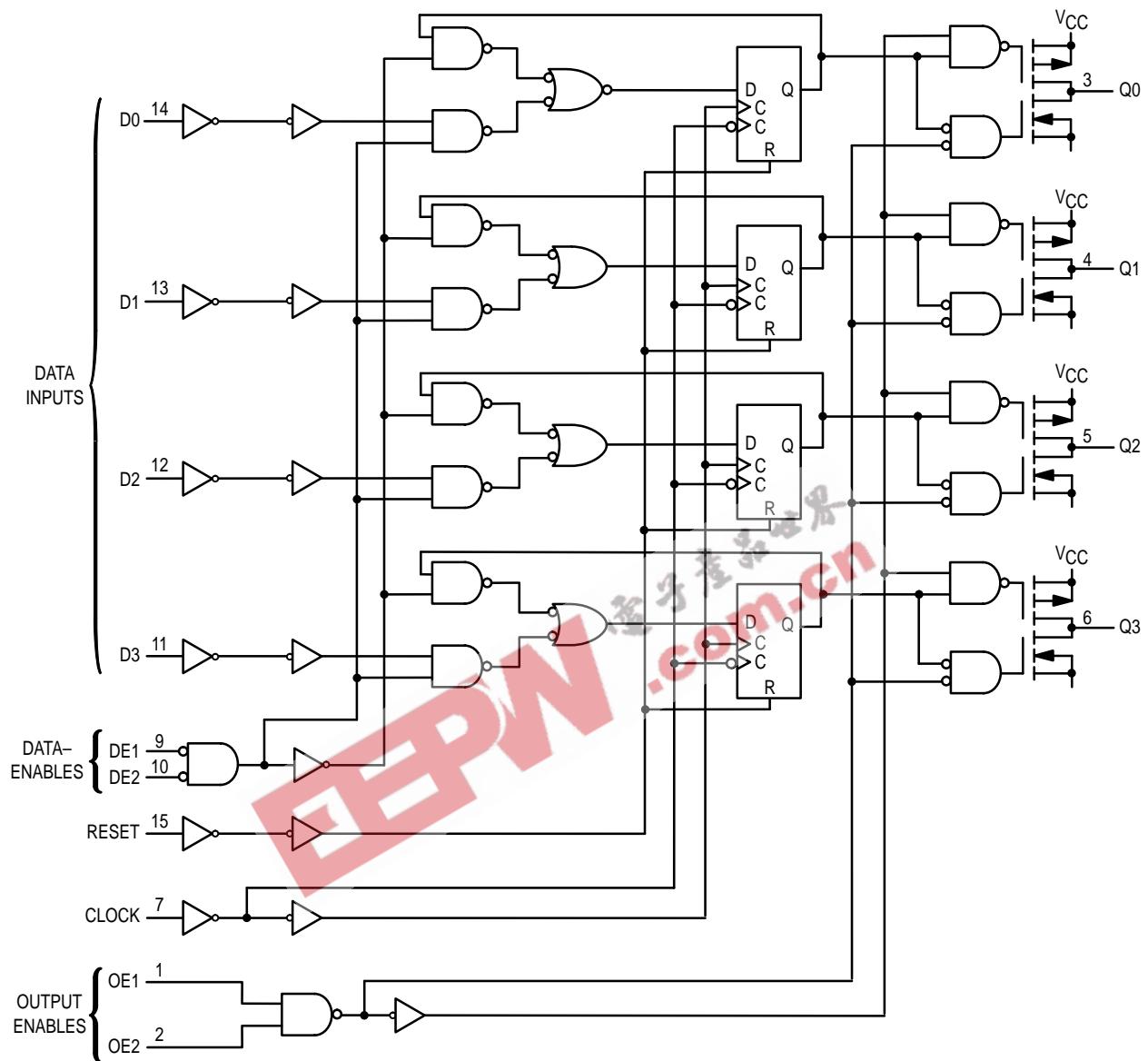
Figure 5.

* Includes all probe and jig capacitance

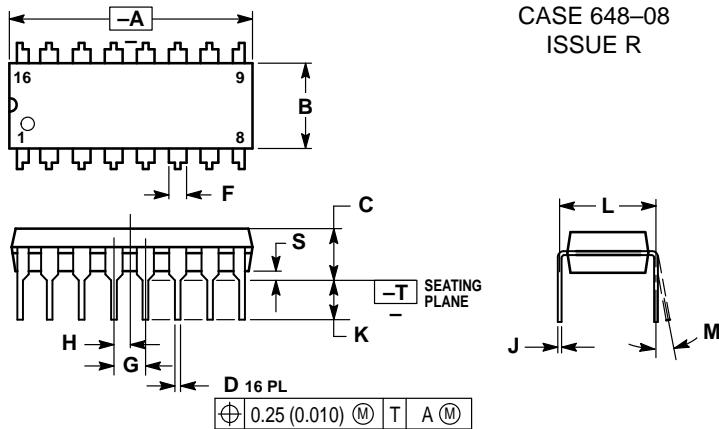
Figure 6.

MC74HC173A

LOGIC DETAIL



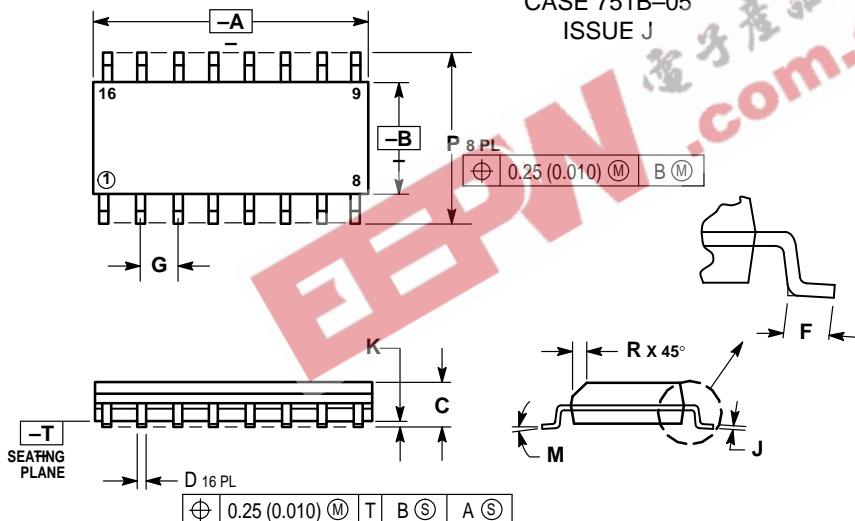
OUTLINE DIMENSIONS

N SUFFIX
PLASTIC PACKAGE
CASE 648-08
ISSUE R


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
5. ROUNDED CORNERS OPTIONAL.

| DIM | INCHES | | MILLIMETERS | |
|-----|-----------|-------|-------------|-------|
| | MIN | MAX | MIN | MAX |
| A | 0.740 | 0.770 | 18.80 | 19.55 |
| B | 0.250 | 0.270 | 6.35 | 6.85 |
| C | 0.145 | 0.175 | 3.69 | 4.44 |
| D | 0.015 | 0.021 | 0.39 | 0.53 |
| F | 0.040 | 0.070 | 1.02 | 1.77 |
| G | 0.100 BSC | | 2.54 BSC | |
| H | 0.050 BSC | | 1.27 BSC | |
| J | 0.008 | 0.015 | 0.21 | 0.38 |
| K | 0.110 | 0.130 | 2.80 | 3.30 |
| L | 0.295 | 0.305 | 7.50 | 7.74 |
| M | 0° | 10° | 0° | 10° |
| S | 0.020 | 0.040 | 0.51 | 1.01 |

D SUFFIX
PLASTIC SOIC PACKAGE
CASE 751B-05
ISSUE J


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|-------|-----------|-------|
| | MIN | MAX | MIN | MAX |
| A | 9.80 | 10.00 | 0.386 | 0.393 |
| B | 3.80 | 4.00 | 0.150 | 0.157 |
| C | 1.35 | 1.75 | 0.054 | 0.068 |
| D | 0.35 | 0.49 | 0.014 | 0.019 |
| F | 0.40 | 1.25 | 0.016 | 0.049 |
| G | 1.27 BSC | | 0.050 BSC | |
| J | 0.19 | 0.25 | 0.008 | 0.009 |
| K | 0.10 | 0.25 | 0.004 | 0.009 |
| M | 0° | 7° | 0° | 7° |
| P | 5.80 | 6.20 | 0.229 | 0.244 |
| R | 0.25 | 0.50 | 0.010 | 0.019 |

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